N-Channel Power MOSFET 60 V, 43 A, 18 m Ω

Features

- Low Gate Charge
- Fast Switching
- High Current Capability
- 100% Avalanche Tested
- These Devices are Pb-Free, Halogen Free and are RoHS Compliant

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Parar	Symbol	Value	Unit		
Drain-to-Source Voltag	Drain-to-Source Voltage			60	V
Gate-to-Source Voltage	e – Contir	nuous	V_{GS}	±20	V
Gate–to–Source Voltage – Non–Repetitive (t _p < 10 μs)			V_{GS}	±30	V
Continuous Drain		T _C = 25°C	I _D	43	Α
Current (R _{θJC})	Steady	T _C = 100°C		31	
Power Dissipation $(R_{\theta JC})$	State	T _C = 25°C	P_{D}	71	W
Pulsed Drain Current t _p = 10 μs			I _{DM}	192	Α
Operating Junction and Storage Temperature			T _J , T _{stg}	-55 to 175	°C
Source Current (Body Diode)			I _S	43	Α
Single Pulse Drain-to-Source L = 0.1 mH			E _{AS}	36	mJ
Avalanche Energy			I _{AS}	27	Α
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			T _L	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case (Drain)	$R_{\theta JC}$	2.1	°C/W
Junction-to-Ambient - Steady State (Note 1)	$R_{\theta JA}$	49	

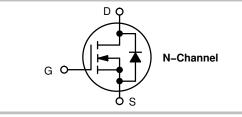
^{1.} Surface-mounted on FR4 board using a 650 mm², 2 oz. Cu pad.



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V _{(BR)DSS} R _{DS(on)} MAX		I _D MAX		
60 V	18 mΩ @ 10 V	43 A		



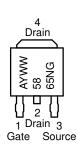


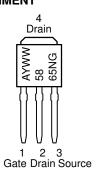
DPAK CASE 369C (Surface Mount) STYLE 2



IPAK CASE 369D (Straight Lead) STYLE 2

MARKING DIAGRAMS & PIN ASSIGNMENT





A = Assembly Location*

Y = Year

WW = Work Week

5865N = Device Code

G = Pb-Free Package

* The Assembly Location code (A) is front side optional. In cases where the Assembly Location is stamped in the package, the front side assembly code may be blank.

ORDERING INFORMATION

See detailed ordering and shipping information in the package dimensions section on page 5 of this data sheet.

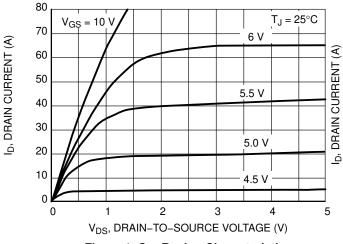
ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise noted)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS							•
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		60			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	$V_{(BR)DSS}/T_J$				59.2		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	V _C c = 0 V	T _J = 25°C			1.0	μΑ
		$V_{GS} = 0 \text{ V},$ $V_{DS} = 60 \text{ V}$	T _J = 150°C			100	
Gate-to-Source Leakage Current	I _{GSS}	V _{DS} = 0 V, V _{GS}	_S = ±20 V			±100	nA
ON CHARACTERISTICS (Note 2)	•				•		
Gate Threshold Voltage	$V_{GS(TH)}$	$V_{GS} = V_{DS}, I_D$	= 250 μΑ	2.0		4.0	V
Negative Threshold Temperature Coefficient	V _{GS(TH)} /T _J				8.6		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 V, I _I	_O = 20 A		14	18	mΩ
Forward Transconductance	gFS	V _{DS} = 15 V, I _I	_O = 20 A		6.9		S
CHARGES, CAPACITANCES AND GA	TE RESISTANCE	S			•	•	•
Input Capacitance	C _{iss}	$V_{GS} = 0 \text{ V, f} = 1.0 \text{ MHz,} $ $V_{DS} = 25 \text{ V}$			1261		pF
Output Capacitance	C _{oss}				136		
Reverse Transfer Capacitance	C _{rss}	• 08 – 20			85		
Total Gate Charge	$Q_{G(TOT)}$				23		nC
Threshold Gate Charge	Q _{G(TH)}	$V_{GS} = 10 \text{ V}, V_{DS} = 48 \text{ V},$ $I_{D} = 38 \text{ A}$			1.5		
Gate-to-Source Charge	Q _{GS}				6.7		
Gate-to-Drain Charge	Q_{GD}				7.7		
Gate Resistance	R_{G}				1.5		Ω
SWITCHING CHARACTERISTICS (Not	e 3)						
Turn-On Delay Time	t _{d(on)}				10		ns
Rise Time	t _r	$V_{GS} = 10 \text{ V}, V_{E}$	nn = 48 V,		17		
Turn-Off Delay Time	t _{d(off)}	$I_D = 38 \text{ A}, R_G$	= 2.5 Ω		20		
Fall Time	t _f				3.5		
DRAIN-SOURCE DIODE CHARACTER	RISTICS						
Forward Diode Voltage	I Diode Voltage V_{SD} $V_{GS} = 0 \text{ V},$ $T_{J} = 25^{\circ}\text{C}$		$T_J = 25^{\circ}C$		0.94	1.2	V
		$I_{S} = 38 \text{ A}$ $T_{J} = 125^{\circ}\text{C}$			0.85		
Reverse Recovery Time	t _{RR}	$V_{GS} = 0$ V, $dls/dt = 100$ A/ μ s, $l_S = 38$ A			23		ns
Charge Time	ta				17		1
Discharge Time	tb				6		1
Reverse Recovery Charge	Q _{RR}				20		nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions. 2. Pulse Test: Pulse Width $\leq 300~\mu s$, Duty Cycle $\leq 2\%$. 3. Switching characteristics are independent of operating junction temperatures.

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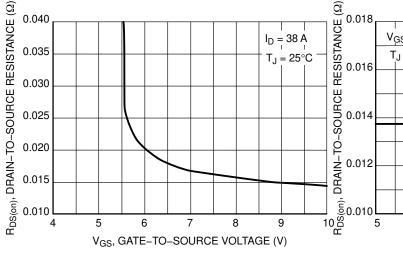
 $V_{DS} \ge 10 \text{ V}$



60 50 40 30 25°C 20 10 -55°C 2 3 5 V_{GS}, GATE-TO-SOURCE VOLTAGE (V)

Figure 1. On-Region Characteristics

Figure 2. Transfer Characteristics



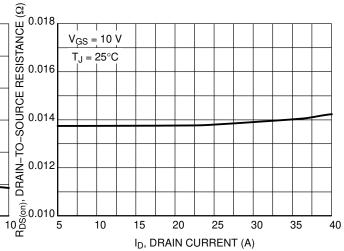
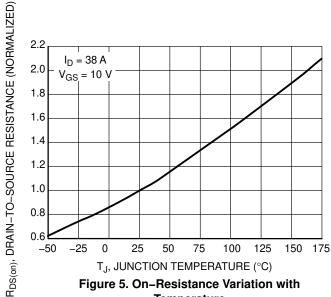
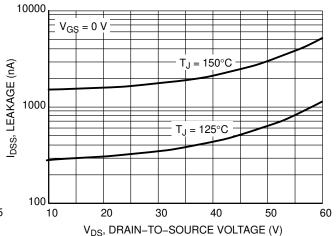


Figure 3. On-Resistance vs. Gate Voltage

Figure 4. On-Resistance vs. Drain Current





Temperature

Figure 6. Drain-to-Source Leakage Current vs. Voltage

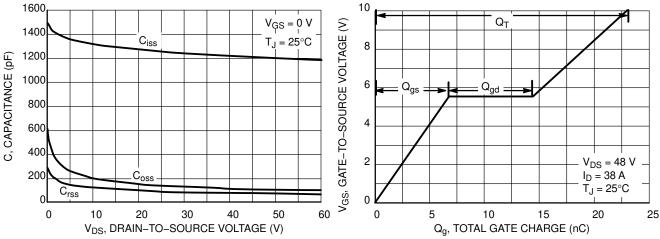


Figure 7. Capacitance Variation

Figure 8. Gate-to-Source vs. Total Charge

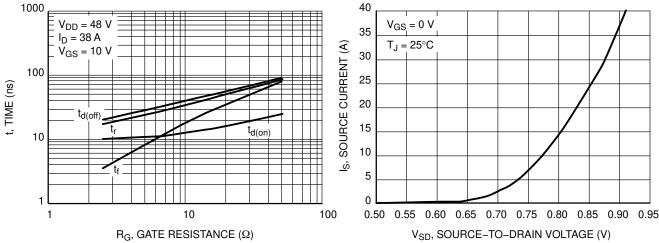


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

Figure 10. Diode Forward Voltage vs. Current

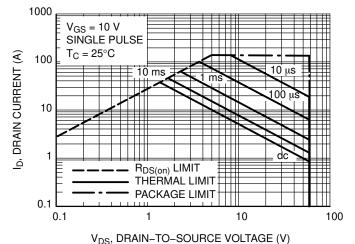


Figure 11. Maximum Rated Forward Biased
Safe Operating Area

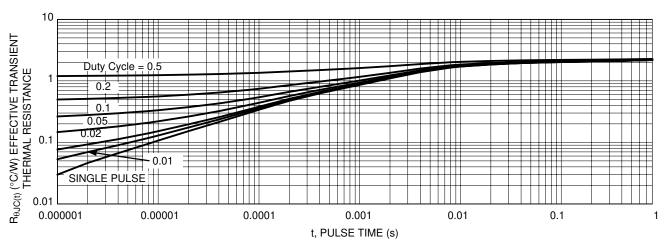


Figure 12. Thermal Response

ORDERING INFORMATION

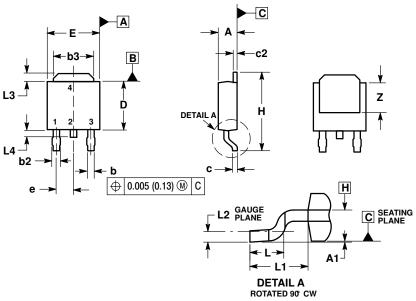
Order Number	Package	Shipping [†]
NTD5865N-1G	IPAK (Straight Lead) (Pb-Free)	75 Units / Rail
NTD5865NT4G	DPAK (Pb-Free)	2500 / Tape & Reel

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

PACKAGE DIMENSIONS

DPAK (SINGLE GUAGE)

CASE 369AA **ISSUE B**



- NOTES:

 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.

 2. CONTROLLING DIMENSION: INCHES.

 3. THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSIONS b3, L3 and Z.
- MENSIONS b3, L3 and Z.

 4. DIMENSIONS D AND E DO NOT INCLUDE MOLD
 FLASH, PROTRUSIONS, OR BURRS. MOLD
 FLASH, PROTRUSIONS, OR GATE BURRS SHALL
 NOT EXCEED 0.006 INCHES PER SIDE.

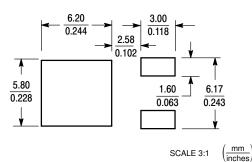
 5. DIMENSIONS D AND E ARE DETERMINED AT THE
 OUTERMOST EXTREMES OF THE PLASTIC BODY.

 6. DATUMS A AND B ARE DETERMINED AT DATUM
 PLANE H.

	INCHES		MILLIMETERS		
DIM	MIN	MAX	MIN	MAX	
Α	0.086	0.094	2.18	2.38	
A1	0.000	0.005	0.00	0.13	
b	0.025	0.035	0.63	0.89	
b2	0.030	0.045	0.76	1.14	
b3	0.180	0.215	4.57	5.46	
С	0.018	0.024	0.46	0.61	
c2	0.018	0.024	0.46	0.61	
D	0.235	0.245	5.97	6.22	
E	0.250	0.265	6.35	6.73	
е	0.090	BSC	2.29 BSC		
Н	0.370	0.410	9.40	10.41	
L	0.055	0.070	1.40	1.78	
L1	0.108 REF		2.74 REF		
L2	0.020 BSC		0.51 BSC		
L3	0.035	0.050	0.89	1.27	
L4		0.040		1.01	
Z	0.155		3.93		

STYLE 2: PIN 1. GATE 2. DRAIN 3. SOURCE 4. DRAIN

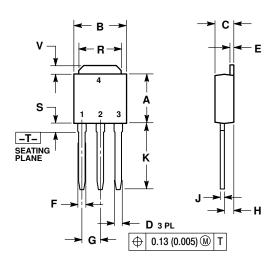
SOLDERING FOOTPRINT*

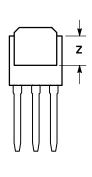


*For additional information on our Pb–Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

PACKAGE DIMENSIONS

IPAK CASE 369D ISSUE C





NOTES:

- AND LES.

 1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.

 2. CONTROLLING DIMENSION: INCH.

	INCHES		MILLIMETERS		
DIM	MIN	MIN MAX		MAX	
Α	0.235	0.245	5.97	6.35	
В	0.250	0.265	6.35	6.73	
С	0.086	0.094	2.19	2.38	
D	0.027	0.035	0.69	0.88	
Е	0.018	0.023	0.46	0.58	
F	0.037	0.045	0.94	1.14	
G	0.090 BSC		2.29 BSC		
Н	0.034	0.040	0.87	1.01	
J	0.018	0.023	0.46	0.58	
K	0.350	0.380	8.89	9.65	
R	0.180	0.215	4.45	5.45	
S	0.025	0.040	0.63	1.01	
٧	0.035	0.050	0.89	1.27	
Z	0.155		3.93		

STYLE 2:

PIN 1. GATE 2. DRAIN

- SOURCE DRAIN

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